



SHEET 1 OF 1

LIST OF ART CITED BY APPLICANT  
(PTO-1449)ATTY. DOCKET NO.  
CIT/K-0019CAPPLN. SERIAL NO.  
10/648,297APPLICANT(S)  
Jong Geun YOON, Myung Seop KIM, Hyoung  
Yun OH, and Sung Tae KIMFILING DATE  
August 27, 2003GROUP  
1774

## U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	FILING DATE
MeY	6,130,001	10/2000	Shi et al.	<del>428</del> 428	690	—
MeY	5,932,363	08/1999	Hu et al.	428	690	—
MeY	5,739,635	04/1998	Wakimoto, Takeo	315	504	—
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MeY	4,356,429	10/1982	Tang, Ching W.	313	503	—

## U.S. PATENT APPLICATION PUBLICATIONS

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MeY	2005/0074628	04/2005	Yoon et al.	428	690	—

## U.S. PATENT APPLICATIONS

	*APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS	

## FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
MeY	JP 09-268283	10/14/1997	Japan (English Abstract and Japanese Full Text)	—	—	X	
MeY	JP 09-199278	07/31/1997	Japan (English Abstract and Japanese Full Text)	—	—	X	
MeY	JP 09-045479	02/14/1997	Japan (English Abstract and Japanese Full Text)	—	—	X	
MeY	JP 08-199161	08/06/1996	Japan (English Abstract and Japanese Full Text)	—	—	X	
MeY	JP 07-331237	12/19/1995	Japan (English Abstract and Japanese Full Text)	—	—	X	
MeY	JP 06-172665	06/21/1994	Japan (English Abstract and Japanese Full Text)	—	—	X	

## OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)

MeY	Japanese Office Action dated December 19, 2006.

EXAMINER

Marie R. Yamaitzky

DATE CONSIDERED

May 31, 2007

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

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